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# **Optical absorption and thermal conductivity of GaAsPN absorbers grown on GaP in view of their use in multijunction solar cells**

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## **Abstract**

The optical absorption and thermal conductivity of GaAsPN absorbers are investigated by means of optical absorption spectroscopy and photo-thermal deflection spectroscopy (PDS) for different 100nm-thick GaAsNP/GaP samples under different growth conditions and various post-growth annealing temperatures. It is first shown that the As content strongly modifies the optical absorption spectrum of the GaAsPN: with a maximum absorption coefficient of  $38000 \text{ cm}^{-1}$  below the GaP bandgap energy. The optical absorption and thermal conductivities of the samples are then evaluated for various growth and annealing conditions using PDS: the results showing overall agreement with optical absorption spectroscopy measurements. A significant improvement in optical absorption and thermal conductivity after annealing is demonstrated. The best thermal conductivity measured is equal to  $4 \text{ W/mK}$ . These results are promising for the development of absorbers in multijunction solar-cell architecture.

## I. Introduction

It has been recently suggested that InGaP/Si and GaAsP/SiGe tandem photovoltaic solar cells would reach high conversion efficiency on the low cost Si substrate [1-3]. GaAsPN alloys which are grown either by molecular beam epitaxy (MBE) or metalorganic vapor phase epitaxy (MOVPE) are very attractive materials for multi-junction solar cells [5-8]. This is due to the high radiative efficiency and the possibility of lattice matching with GaP [4], and more particularly with Si substrates [5,6]. Although the incorporation of N into GaAsP was found to be at the origin of its excellent optical emission properties [9-11], the optical absorption properties of this alloy have not yet been studied in detail for compositions of interest for tandem solar cell development [12]. Moreover, while the thermal conductivity of the GaAsP and GaAsN alloys have been measured [13,14], the GaAsPN thermal properties have not yet been determined, despite its obvious importance for heat dissipation during photovoltaic conversion. More specifically, it is known that the greater the N content, the greater the degradation of the crystalline quality; lattice order of the crystal; and change in the physical properties of the alloy. This effect could be related to the non-uniformity in the distribution of nitrogen and the appearance of various defects such as vacancies, interstitial N atoms and N clustering, that enhances the non-radiative recombination and localization of the carriers. According to different studies [15, 16], post-growth, rapid thermal annealing (RTA) could be an effective way to limit these effects and improve the optical properties of GaPN-based alloys. Temperature-dependent photoluminescence (PL), PL excitation and time-resolved PL measurements have shown a reduction of PL intensity quenching, and a significant improvement of PL intensity and carrier lifetime at room temperature after post-growth thermal treatment [16].

In this work, we have investigated the optical absorption and thermal properties of GaAsPN absorbers by means of optical absorption spectroscopy and photo-thermal deflection spectroscopy (PDS). The influence of growth conditions and post-growth annealing on optical and thermal parameters is considered.

## II. Theory

Here, we used photo-thermal deflection spectroscopy (PDS) to characterize the GaAsPN/GaP samples. The PDS is a very powerful and sensitive technique to measure to an absorbance value as low as roughly  $10^{-5}$ , and has several advantages in the investigation

of low absorption coefficients in semiconductors [17, 18]. On the flip side, the PDS signal depends on the optical and thermal properties of the sample, which can be inferred through extensive modeling [17-20].

The principle of PDS consists of illuminating the sample by means of a modulated monochromatic light beam. The energy absorbed is then converted into heat through non-radiative recombination processes. The thermal wave generated propagates into the sample and the surrounding media, creating a refractive-index gradient, which gives rise to the deflection of a laser probe beam skimming the surface of the sample. The incident light is assumed to be uniform, and only the sample absorbs light: with an absorption coefficient  $\alpha$ . The complex expression of the deflection is given by Murphy et al. [21]:

$$\Psi = \frac{L}{n} \frac{dn}{dT} \sigma_f T_0 \exp(-\sigma_f x_0) \quad (1)$$

where  $n$  is the fluid refractive index;  $x_0$  is the distance between the probe beam and the sample surface;  $L$  is the sample length; and  $T_0$  the rise in temperature at the surface of the sample. In this equation,  $\sigma_f = (1+j)/\mu_f$ , where  $\mu_f = (D/\pi F)^{1/2}$  is the thermal diffusion length in the fluid;  $D$  is the thermal diffusivity; and  $F$  is the modulation frequency of the heat source. The amplitude of deflection is proportional to  $|T_0|$  and the phase is

$$\arg(\Psi) = \frac{-x_0}{\mu_f} + \frac{\pi}{4} + \theta. \quad \text{The temperature } T_0 \text{ is calculated by solving the one dimension heat}$$

equation in the different media (the sample, the backing and the surrounding fluid) (see figure 1):

$$\frac{\partial^2 T_f}{\partial x^2} - \frac{1}{D_f} \frac{\partial T_f}{\partial t} = 0 \quad \text{if} \quad h \leq x \leq h + h_f \quad (2)$$

$$\frac{\partial^2 T_l}{\partial x^2} - \frac{1}{D_l} \frac{\partial T_l}{\partial t} = A_l \quad \text{if} \quad 0 \leq x \leq h \quad (3)$$

$$\frac{\partial^2 T_s}{\partial x^2} - \frac{1}{D_s} \frac{\partial T_s}{\partial t} = A_s \quad \text{if} \quad -l \leq x \leq 0 \quad (4)$$

$$\frac{\partial^2 T_b}{\partial x^2} - \frac{1}{D_b} \frac{\partial T_b}{\partial t} = 0 \quad \text{if} \quad -l_b - l \leq x \leq -l \quad (5)$$

Where  $\sigma_i = (1+j)/\mu_i$  and  $\mu_i = (D_i/\pi F)^{1/2}$  corresponds to thermal diffusion length in the  $i^{\text{th}}$  medium. The index  $i$  takes the subscripts f, l, s, and b respectively for the fluid, layer, substrate and backing. In these equations,  $A_l = \frac{-dI_l}{2Kdx}$ , and  $A_s = \frac{-dI_s}{2K_s dx}$  where the quantities  $A_l$ ,  $A_s$ ,  $I_l$ ,  $I_s$ ,  $K$  and  $K_s$  are used respectively to describe the thermal source generated by the absorption, the intensity of light in layer l and substrate s, and the thermal conductivity in both the layer and the substrate. Finally, solving the heat equations in different media, and the application of the boundary conditions of temperature and heat flux at different interfaces allows us to determine an expression for the rise in temperature at the surface of the sample  $T_0$  [22, 23]:

$$T_0 = \frac{\left\{ \begin{array}{l} E[(1-r_s)(b+1)\exp(\sigma_s l) - (1-b)(1+r_s)\exp(-\sigma_s l) - 2(b-r_s)\exp(-\alpha_s l)] \\ + Z[(1-r_c)(b+1)\exp(\sigma_s l) - (1-b)(1+r_s)\exp(-\sigma_s l)][1 - \exp(-\alpha_c h)] \end{array} \right\}}{[(1-g)(1-b)\exp(-\sigma_s l) + (1+g)(1+b)\exp(\sigma_s l)]} \quad (6)$$

### III. Experimental details

GaAsPN absorbers were grown on GaP(001) substrates by Molecular Beam Epitaxy (MBE) using a Riber Compact 21 solid-source MBE system [24]. Nitrogen was incorporated using a valved RF plasma source with a nominal 0.5 sccm  $N_2$  flow and a RF power of 400 W [11]. A V/III beam equivalent pressure ratio was set equal to or greater than 10 in order to control the incorporation of nitrogen [25, 26].

In the first set of four 100 nm-thick samples (referred hereafter as S1), the As flux was varied while maintaining the P flux constant to vary the As/P ratio and to change the As content in the sample: thus leading to As nominal compositions of 5, 10, 30 and 40% respectively, and nominal N content of 2% (which is assumed to increase from one sample to the other within 2%: with the roughness induced by the strain relaxation) [26]. All these samples were annealed under an  $N_2H_2$  flow at 800°C for 1 minute in an RTA oven.

In the second set of two 1  $\mu\text{m}$ -thick samples (referred hereafter as S2), the As nominal composition was set equal to 10% with an N content of around 2% (i.e. a  $\text{GaAs}_{0.10}\text{P}_{0.88}\text{N}_{0.02}$  alloy). The nitrogen content for these two samples is not exactly similar for both cases, as the incorporation of nitrogen (amount and nature of the incorporation, e.g. interstitial or substitutional) is dependent on the growth temperature. In this case, the alloy is lattice-matched to the GaP substrate, and therefore no relaxation occurs during the growth [11]. For both samples, growth temperatures were respectively 450°C and 480°C (as measured by an optical pyrometer), while other growth parameters were kept constant. Each sample was divided into 3 pieces which were respectively (i) annealed under a  $\text{N}_2\text{H}_2$  flow at 800°C for 1 minute, (ii) annealed under a  $\text{N}_2\text{H}_2$  flow at 730°C for 30 minutes, and (iii) not annealed for comparison.

In order to determine absorption spectra, transmission (T), and reflection (R), measurements were performed on a single grating 0.55-meter focal-length monochromator. The optical signal was detected by an Si *pin* photodiode using a lock-in amplifier. The absorption coefficient ( $\alpha$ ) was calculated according to the formula  $\alpha(E) = -\frac{1}{d} \ln\left(\frac{T}{(1-R)^2}\right)$ , where d is the thickness of the GaAsPN film.

For PDS measurements [20, 22, 23], in order to increase the sensitivity of the photothermal signal, the sample was immersed in paraffin-oil-filled cell. As shown in figure 2, the sample was heated by mechanically chopped monochromatic light, produced by a halogen lamp and sent through a monochromator. The deflection of the laser beam probe (He-Ne) was detected with a four quadrant photodetector connected to a lock-in amplifier, by which means amplitude and phase of the photothermal signal were measured. The normalized amplitude is the ratio of the measured amplitude obtained with the semiconductor sample to the reference amplitude obtained with a carbon black sample.

## IV. Results and discussion

### A. Optical absorption spectra and bandgap energy of GaAsPN absorbers

Optical absorption coefficients were first optically measured for the set S1 samples as a function of the energy for various As contents, and plotted in **Fig. 3**. As expected, the absorption edge energy decreases as As content increases: 1.4 eV for 40% As; 1.55 eV for 30% As; 1.8 eV for 10% As; and 1.9 eV for 5% As. The maximum absorption coefficient

obtained below the bandgap is reached at  $38000\text{ cm}^{-1}$  for relatively high As contents. This confirms the increase of the conduction-band fractional  $\Gamma$  characteristic with increased As content, as predicted by tight binding calculations [27, 28]. The values are also consistent with previous band-anticrossing calculations, and absorption measurements with different nitrogen contents [12]. With respect to tandem solar cell applications on silicon, the sample with a 10% As content is the most interesting as it guarantees both perfect lattice-matching and an absorption edge in the targeted [1.7-1.8 eV] range of energy [11]. With this configuration, a GaAsPN/Si tandem solar cell would theoretically reach 37% efficiency under AM 1.5G of solar radiation. [8]

In the following, the composition of As is fixed at 10%, and sample set S2 was studied in some detail. The amplitude variations versus wavelength of the experimental normalized photothermal signal in the vicinity of the band gap energy are given in figure 4 (a) and (b) for the two samples of GaAsPN, which were grown at different temperatures under various annealing conditions. The amplitudes measured present two saturation levels for decreasing wavelengths below 640 nm and greater than 690 nm. The comparison between experimental curves and the corresponding theoretical ones [20, 23] permits us to assign for each wavelength the corresponding optical absorption coefficient resulting in the absorption spectra of the studied GaAsPN absorbers, as shown in figure 4. Figure 5 (a) and (b) show the absorption spectra of the two samples of GaAsPN for different growth temperatures and post-growth annealing conditions. From this figure, it is clear that the absorbance increases with increasing annealing temperature despite the shorter annealing time used at  $800\text{ }^{\circ}\text{C}$  (note that samples at  $730\text{ }^{\circ}\text{C}$  annealing for 1 minute were also grown, showing nearly no difference in their optical properties compared to as-grown samples). This result is in contradiction with the one published in ref. [12], in which absorption coefficient is not improved with annealing. This may be attributed to the larger N content, typically around 2%, and the lower annealing temperature used in the present study. Indeed, in this study, we observe that annealing above  $800\text{ }^{\circ}\text{C}$  damages the sample, preventing any improvement in photoluminescence properties. In fig. 3, it is also noticed that samples grown at  $480\text{ }^{\circ}\text{C}$  and annealed at  $800\text{ }^{\circ}\text{C}$  have a larger optical absorption (typically  $40000\text{ cm}^{-1}$  at 1.95 eV) coefficient than those grown at  $450\text{ }^{\circ}\text{C}$  (typically  $25000\text{ cm}^{-1}$  at 1.95 eV). This would tend to show that growth at  $480\text{ }^{\circ}\text{C}$  favors the positioning of nitrogen atoms in crystalline sites, or anti-sites, which are more sensitive to post-growth annealing. Nevertheless, this still remains to be confirmed. Finally, the values obtained for optical absorption coefficients are in overall agreement with values extracted

from direct optical absorption measurements of sample set 1: the small difference may be due to slightly different growth conditions, or light diffusion processes due to the roughness of the sample. This is also confirmed by direct optical absorption measurements performed on the sample grown at 480°C and annealed at 800°C (sample set 2), as illustrated in Fig. 6. In this figure, the corresponding photoluminescence spectrum is also shown. A detailed look at the PL spectrum in Fig. 6 shows it is composed of a low energy tail, usually associated with localized nitrogen states or alloy fluctuations [29], and a different peak at higher energy: around 1.9 eV. This higher energy-peak intensity was greatly improved during the annealing process, and corresponds well to the measured position of the absorption edge: with an associated Stokes shift below 100 meV in this system. This behavior, which is due to carrier localization, is very common in dilute nitride materials such as InGaAsN/GaAs,[30] and was already deeply studied by Karcher *et al.*[29] in the GaAsPN material system. Although it was beyond the scope of this paper we noted that a full analysis could be performed by studying the evolution of the maximum PL peak values with temperature, which displayed an unambiguous S-shaped behavior (not shown here). It is also clear from this figure that the interesting absorption range for tandem solar cell operation with such a GaAsPN absorber is between 1.8 eV and 2.3 eV: corresponding to the delocalized states of the GaAsPN bulk alloy.

Annealing effects on optical absorption near the bandgap is not surprising because the incorporation of N in GaAsP results in the presence of randomly distributed nitrogen clusters and isolated nitrogen impurity states in the crystals [31, 32]. The application of post-growth annealing provides energy (related to the annealing temperature) for the change in group-V atom configuration i.e., a change in the nearest neighbor environment of Ga atoms. This globally leads to the reduction in defect density and an improvement in layer absorption. The effect of annealing on optical properties was also demonstrated in GaInAsN [33, 34], and the increase of GaAsPN/GaP quantum wells photoluminescence efficiency has already been reported [35].

From the experimental data presented here, the following interpretations can be given: (i) Annealing tends to limit the inhomogeneity of the samples (nitrogen localized states, alloy inhomogeneity, non-radiative centers), and favors the emission/absorption of the delocalized GaAsPN states (transition around 1.85 eV in this work). (ii) This effect is dependent on both temperature and annealing time. (iii) The sample grown at higher temperature (480°C) is more homogeneous before annealing than that grown at lower temperature (450°C).

### ***B. Thermal conductivity of GaAsPN***



Thermal conductivity is a major parameter for improving quality and performance of solar cells [36, 37]. High thermal conductivity provides a number of advantages for optoelectronic and photonic devices by dissipating heat while the device is operating [38]. We evaluated the thermal conductivity of the two GaAsPN absorbers studied in sample set S2, which have shown themselves to be promising for use in tandem solar cells [11]. In the vicinity of the bandgap energy, the photothermal signal phase saturates in both high and low absorption regions. In the case of a thin semiconductor layer, the phase difference between the two saturations depends strongly on its thermal conductivity [20, 23]. We obtained the thermal conductivity of the two GaAsPN samples under different annealing conditions by varying the theoretical phase difference  $\Delta\phi_{theo}$  until it is approximately equal to the experimental ones ( $\Delta\phi_{theo} \approx \Delta\phi_{exp}$ ). Figure 7 and 8 show the theoretical and the experimental phases of PDS signal for samples grown at 480°C and 450°C respectively. The extracted thermal conductivity values for samples from set S2 are listed in table 1.

The first conclusion that can be drawn is that thermal conductivity increases with annealing temperature for the two samples presented here, reaching a value above 4 W/mK under the best annealing conditions (800°C) with a 480 °C growth temperature. Reduced overall thermal conductivity is usually associated with phonon scattering at boundaries and crystal point defects, both of which impose additional resistance [38, 39]. But it is also largely affected through the alloying process, [13] or superlattice interfaces [40], by the lattice order of the crystal. In the present study, the improvement of thermal conductivity with annealing is fully consistent with the analysis performed from absorption measurements, revealing better crystalline quality for materials grown at 480 °C and annealed at 800°C. Special attention should be paid to the inhomogeneity of the alloy: the presence of non-radiative centers or localized states are expected to play an important role here. Finally, it was shown in ref. [13] that the GaAs<sub>0.1</sub>P<sub>0.9</sub> alloy has a thermal conductivity of 30 W/mK. Y. Zhao et al. measured the thermal conductivity of GaAsN with 2% of nitrogen to be around 27 W/mK, which is approximately 60% of the GaAs (thermal conductivity is 45 W/mK) binary system [14]. Taking into account the alloy disorder added by the quaternary alloy crystalline structure, as compared to ternary alloys, the values found in this work (around 4W/mK) are therefore consistent with what can be expected from reading the literature.

***Conclusion:***

In this article, optical absorption and thermal conductivity of GaAsPN absorbers were investigated by means of optical absorption spectroscopy and photo-thermal deflection spectroscopy (PDS) for different GaAsPN/GaP samples with different growth conditions and various post-growth annealing temperatures. It was shown that optical absorption is strongly dependent on the As content in the alloy, and that absorbers with 10% of As and 2% of N are the most interesting as they guarantee, for tandem solar cell development on silicon, both the perfect lattice-matching and an absorption edge in the targeted [1.7-1.8 eV] range of energy. It was then shown that absorption spectra and thermal conductivity properties are significantly improved by the post-growth annealing process. This is attributed to the limitation of the structural inhomogeneity, which is larger when the sample has been grown at a lower temperature.

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## Tables

	K (W/mK) As-grown	K (W/mK) GaAsPN (730°C)	K (W/mK) of GaAsPN (800°C)
$\Gamma_g=480^\circ\text{C}$	2.40 (1.25%)	3.80 (0.9%)	4.30 (0.86%)
$\Gamma_g=450^\circ\text{C}$	1.75 (1.1%)	2.10 (1%)	2.30 (1.3%)

**Table 1.** Thermal conductivities of GaAsPN grown at 450°C and 480°C as a function of annealing conditions.

### Figure captions

**Table 1.** Thermal conductivities of GaAsPN grown at 450°C and 480°C as a function of annealing conditions.

**Figure 1.** Outline of the different media used in the model

**Figure 2.** Sketch of the experimental PTD setup.

**Figure 3.** Optical absorption coefficient measured for various As content values (5%, 10%, 30% and 40%) in 100nm-thick GaAsPN absorbers (set of samples S1).

**Figure 4.** Determination of absorption spectrum by comparison between the experimental and theoretical amplitude for the GaAsPN layers grown at 480°C (a) and 450°C (b) (set of samples S2).

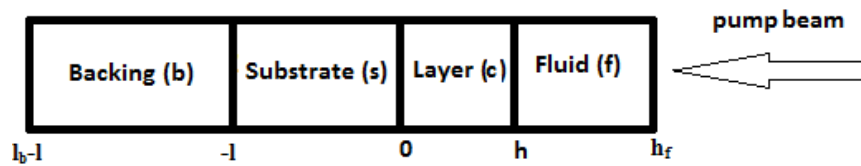
**Figure 5.** Absorption spectra of GaAsPN layers grown at 480°C ((a) and 450°C (b) (set of samples S2).

**Figure 6.** Room temperature photoluminescence spectra of GaAsPN grown at  $T_g=480^\circ\text{C}$  (set of samples S2) annealed at 800 °C, with the corresponding absorption spectrum

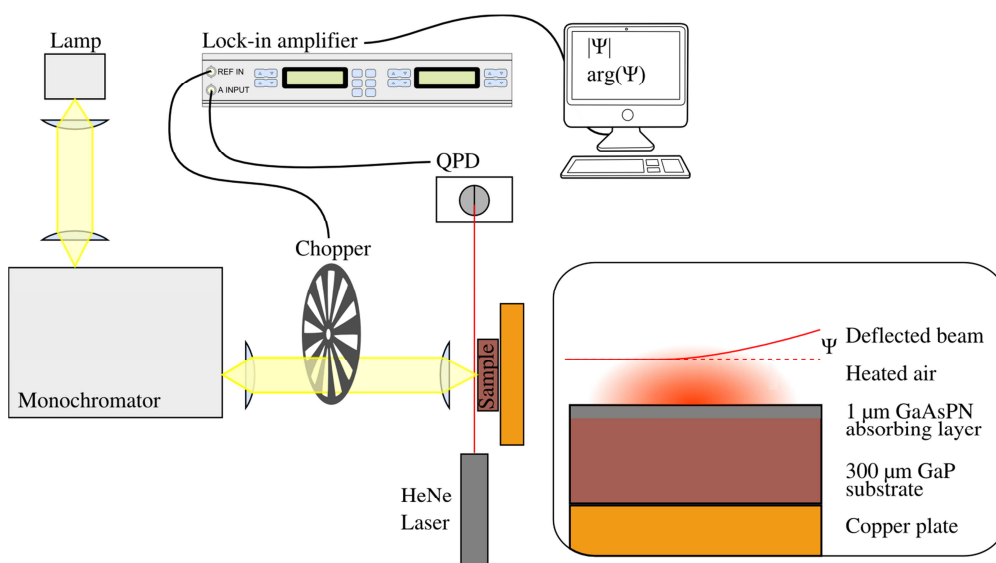
**Figure 7.** Comparison between experimental and theoretical phase difference near the gap layer of GaAsPN grown at 480 °C (set of samples S2).

**Figure 8.** Comparison between experimental and theoretical phase difference near the gap layer of GaAsPN grown at 450 °C (set of samples S2).

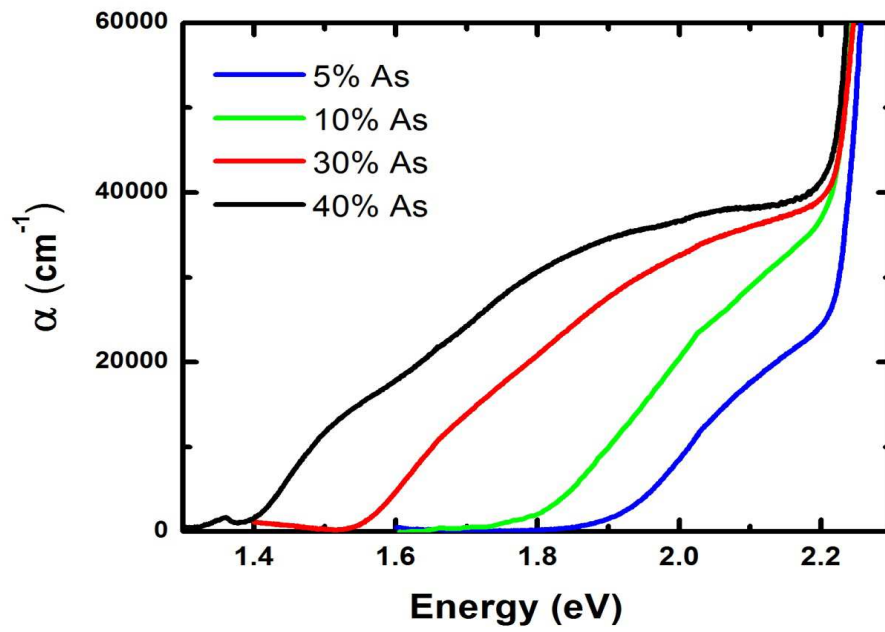




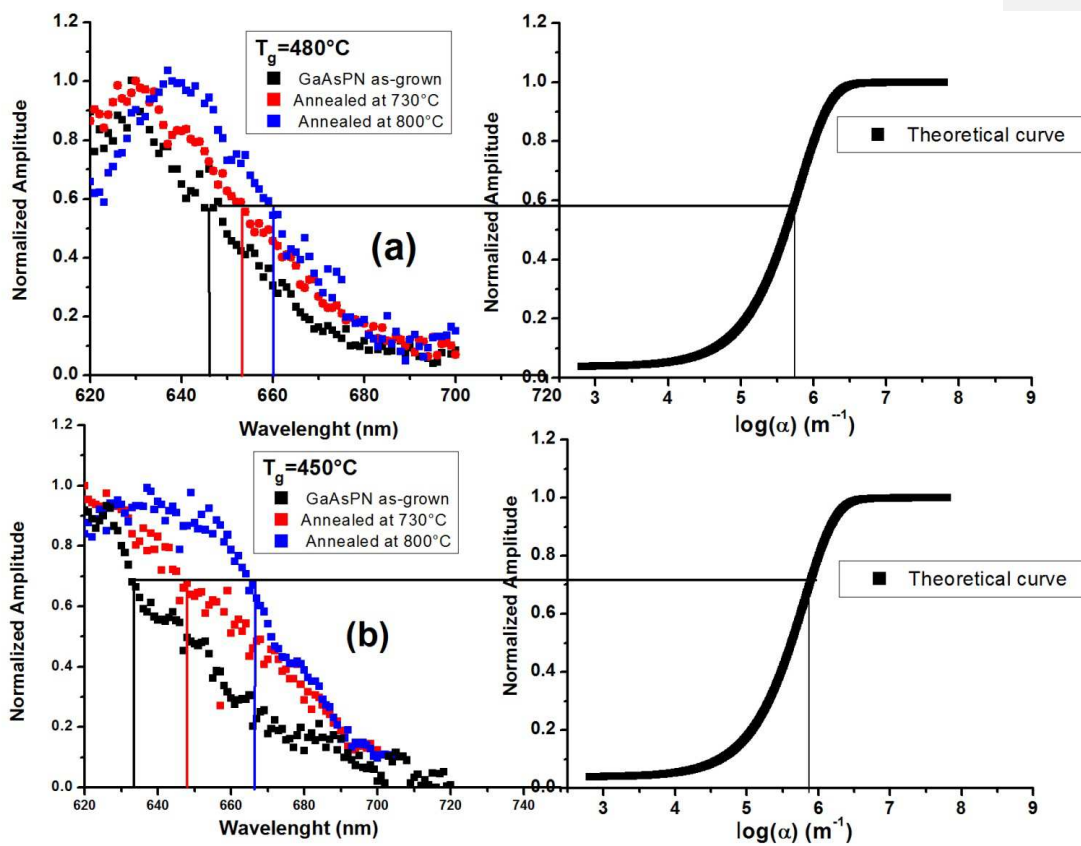
**Figure 1.** Outline of the different media used in the model



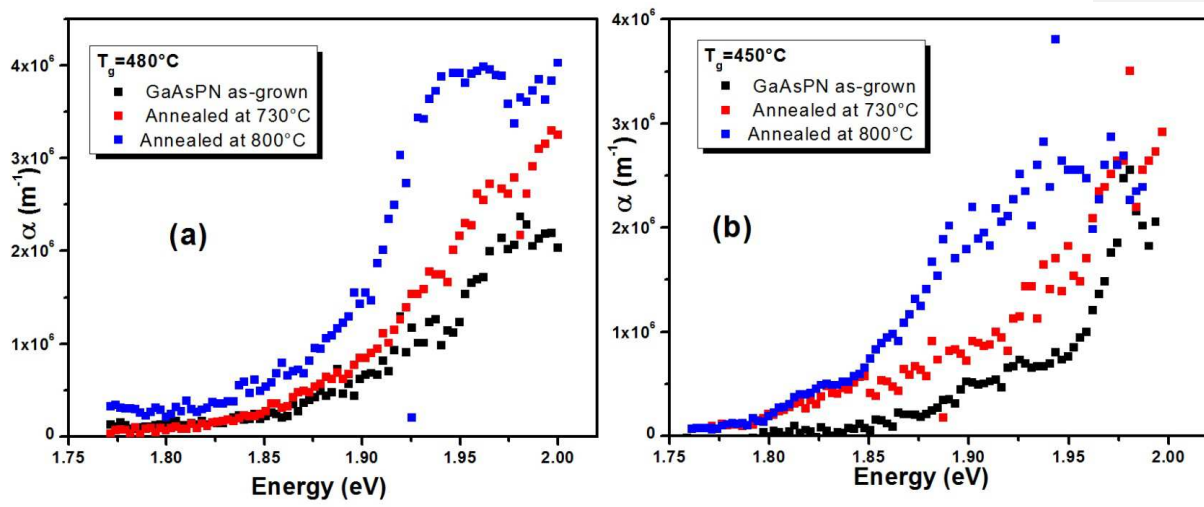
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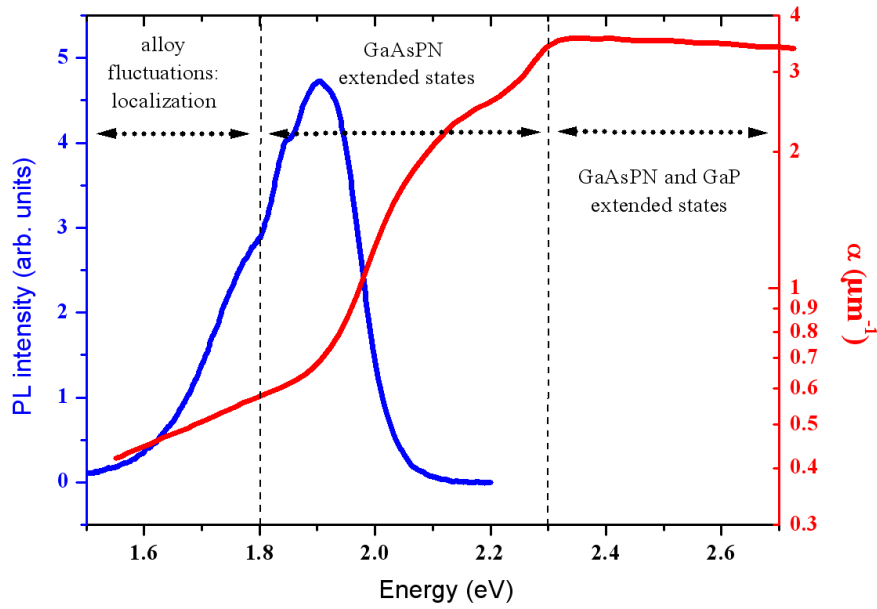
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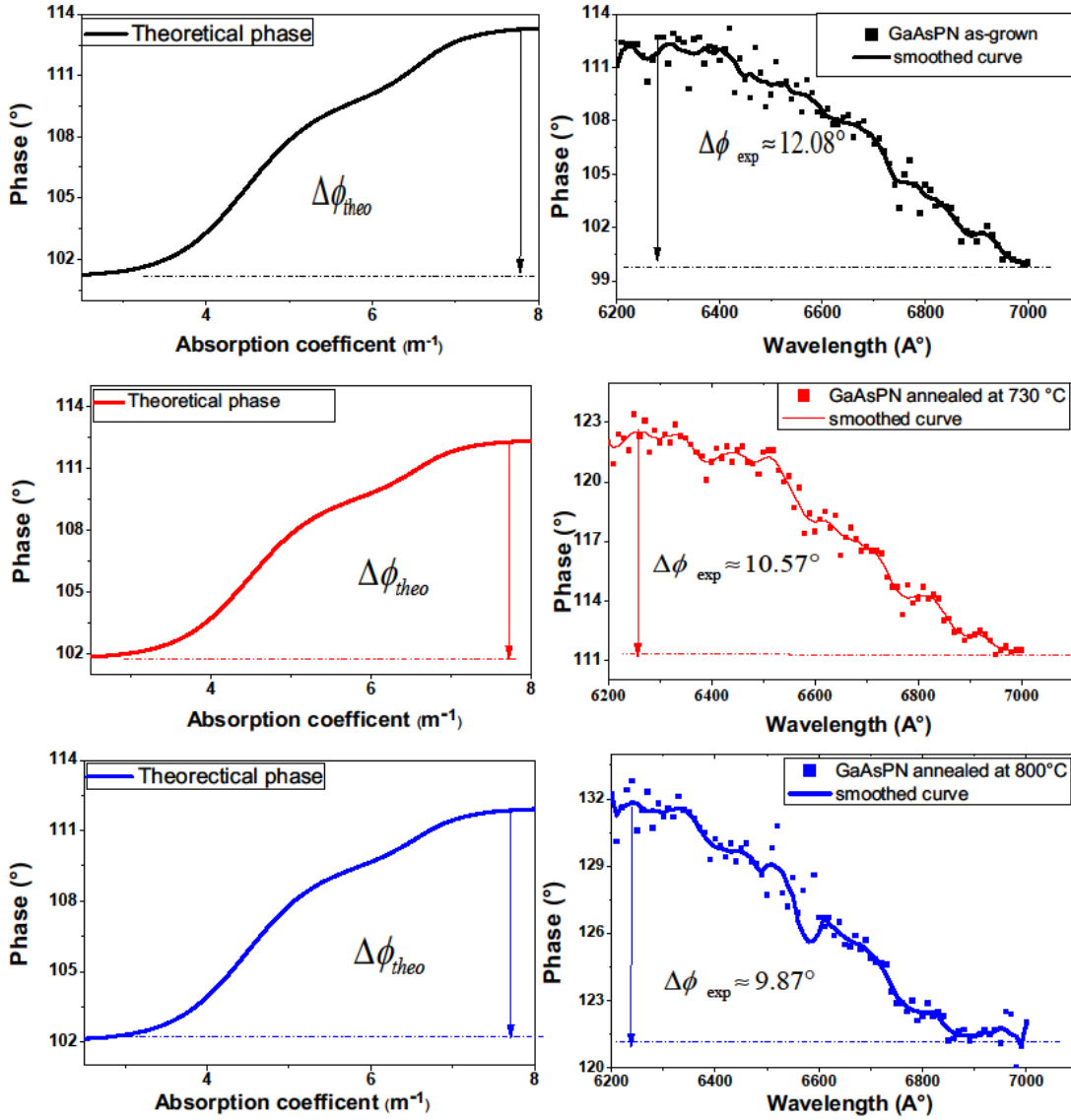


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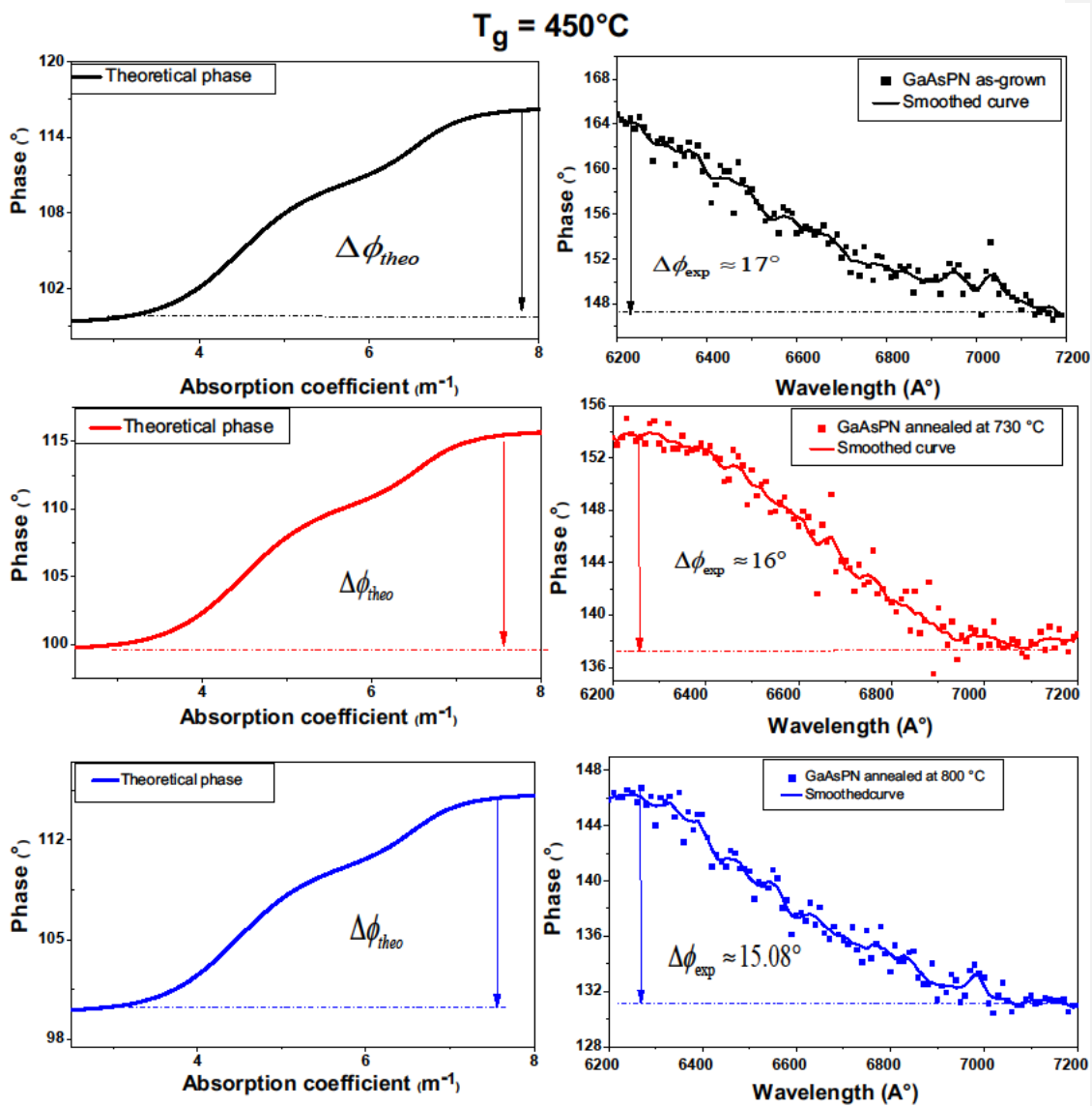


**Figure 6.** Room temperature photoluminescence spectra of GaAsPN grown at  $T_g=480^\circ\text{C}$  (set of samples S2) annealed at  $800^\circ\text{C}$ , with the corresponding absorption spectrum.

$T_g = 480^\circ\text{C}$



**Figure 7.** Comparison between experimental and theoretical phase difference near the gap layer of GaAsPN grown at 480 °C (set of samples S2).



**Figure 8.** Comparison between experimental and theoretical phase difference near the gap layer of GaAsPN grown at 450 °C (set of samples S2).